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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT  MASAKO NUKAGA ET AL							
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<<	AO	3-288406	12/18/91	JAPAN (w/English Abstract)					х		
5/5	AP	7-157313	06/20/95	JAPAN (w/English Abstract)					х		
45	AQ	8-288116	11/01/96	JAPAN (w/English Abstract)				1	×	,	
45	AR	7-61821	03/07/95	JAPAN (w/English Abstract)					х		
\$3	AS	56-10767	03/10/81	JAPAN		T			х		
55	AT	56-31288	07/20/81	JAPAN					х		
	AU										
	AV										
	·	OTHER REF	ERENCES (	Including Author, Title, Date, Pertiner	nt Pages,	etc.)					
55	AW	M. Nukaga et al., "Relationship between the Magnetic Properties of YIG Ferrites and the IMD (Intermodulation Distortion) of an Isolator, Journal of the Applied Magnetics Association of Japan, Vol. 22, No. 4-2, (1998), p. 673-676									
53	AX	INTERNATIONAL SEARCH REPORT of PCT/JP99/01996 dated July 1999.								<del>7</del> .	
Examiner	· 	the 2 1	<b></b>			onsidered	1/1	3/03	5		
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